

IMPLEMENTATION OF LOW POWER ACTIVE SECURITY MESH

By

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List of Abbreviations and Nomenclature

Abbreviation	Meaning
ATM	Automated Teller Machine
BC	Bit Comparator
CMP	Chemical Mechanical Planarization
DIP	Dual Inline Package
DRC	Design Rule Check
DRSAS	Dense Random Spaghetti Active Shield
FIB	Focused Ion Beam
GDS	Graphic Database System
HM	Hard Macro
IB	Inverter Block
IC	Integrated Circuit
LB	Litar Bersepadu
LFSR	Linear Function Shift Register
LKAC	Litar Keselamatan Anti-Ceroboh
LMC	Laser Micro Chemical
Mx	Metal in the lower stack, has higher resistance
My	Metal in the middle stack, has lower resistance than Mx layers
Mz	Metal in the highest stack, has lowest resistance
PBG	Pseudorandom Bit generator
PVT	Process, voltage, temperature
RDL	Redistribution Layer
RE	Reverse Engineering
SEM	Scanning Electron Microscope
TV	Television
JTAG	Joint Test Action Group
BIST	Built-In Self-Test

Implementasi Litar Keselamatan Anti-Ceroboh Berkuasa Rendah

Abstrak

Keselamatan Litar Bersepadu(LB) merupakan isu besar kepada banyak syarikat korporat kerana banyak peranti tiruan telah wujud di pasaran. Banyak langkah keselamatan telah diambil untuk mengatasi masalah ini seperti litar keselamatan anti ceroboh(LKAC), litar cegah gangguan voltan dan penyulitan data. Kebanyakan LB hanya beroperasi pada satu frekuensi sahaja. Ini sangat merugikan kuasa apabila LB tidak membuat apa-apa operasi. Kajian ini bertujuan mereka LKAC yang mudah dan berkuasa rendah. Ia juga menguji beberapa frekuensi untuk mendapatkan jumlah kuasa yang rendah. Jumlah kuasa dibanding antara LKAC asal dan LKAC baru. LKAC baru menggunakan peranti logik yang optimum dan beroperasi pada frekuensi yang lebih rendah. Kuasa akan dikira menggunakan anggaran “spice”. Kajian berikutnya membandingkan jumlah kuasa yang digunakan oleh LKAC yang baru melalui Spice dan melalui perisian penganalisa kuasa seperti RedHawk. Tujuan kajian ini adalah untuk membuktikan penjimatan kuasa. Berdasarkan kedua kajian di atas, boleh dirumuskan bahawa pengurangan peranti logik dan kawalan frekuensi yang optimum boleh mengurangkan penggunaan kuasa sebanyak 96.6%. Nilai ini adalah satu anggaran yang pesimistik dan jumlah penjimatan adalah lebih tinggi sebenarnya. Jadi, keselamatan LB boleh dijaga dan jumlah kuasa boleh dijimatkan semasa LB tidak beroperasi.

Implementation of Low Power Active Security Mesh

Abstract

Integrated Chip (IC) security has been a big concern for companies and consumers as the number of counterfeit devices have increased tremendously. Many counter-measures have been taken to improve the chip security like anti-tamper mesh, glitch protection and encryptions. The current anti tamper mesh usually runs on a single frequency and would consume a lot of power when the chip is idle. An inefficient mesh implementation would cause the die size to increase but the area protected would not be complete. This research will concentrate to make the anti-tamper mesh simple and secure yet, consumes low power. It uses the least resource in terms routing tracks and makes use of several operating frequencies to get the best of power consumption. The power number is compared using standard cell spice simulation numbers. The cells with reduced gate count and reduced frequency are compared with original settings using spice simulation number. The second experiment was done to compare the numbers from the spice simulations against power analysis tool. This is to ensure the spice simulation numbers reflect the power saving and to prove that the savings are real and can be even lower than estimated. Based on the experiments, it can be concluded that varying the frequencies of the active security mesh blocks and reduction of registers used can save power and still maintain the integrity of the active mesh. The spice simulation numbers are pessimistic and in power analysis, it is shown to be much lower. The total power saved by reducing the registers is 34.4%. When the registers and frequency are reduced, the total savings is about 96.6%.

CHAPTER 1

INTRODUCTION

1.1 Overview

Integrated Chip (IC) are an integral part of our life in these modern days. The chips are everywhere, in consumer devices, banking, entertainment, communications devices, transportation and medical industry. The evolution of IC from several transistors in a single chip to billion gates in processors just shows the importance of IC in everyday life. According to Moore's law, the density of gates would double every year driving down the cost, size and doubling in performance. Even digital cameras have zoomed past its older cousin, the exposure film, adding millions of pixels on its way to snatch the supremacy in photography industry.

Healthcare industry is teeming with life as age boundary is pushed further, life expectancy is higher than a century ago. More elderly people are actively participating in everyday activities and contribute till much later part of their life. Many exoskeleton equipment and life support devices have IC in them to do a million calculations and execute the right movement in a short fraction of time.

Transportation is an industry that is very heavily dependent on IC to improve the safety and reliability of the machines. It is no more a component that provides entertainment videos or music but one that is heavily involved in braking, maneuvering and reducing the impact of a collision in cars.

For example, air plane safety standards are so high and without IC, it would be impossible to achieve it. Imagine a fighter jet without the advancement of IC technologies, it would not be able to fly at high speed while keeping an eye on the target.

Banking industry have gone global, contributing to the economy to countries across the globe. People can travel worldwide and conduct transaction everywhere. Automated Teller Machine cards enable people to withdraw cash anytime convenient to them. Security key fobs enable people to conduct electronic banking from the comfort of their homes.

Communications have made the world smaller, with miles of fiber optics and array of technology chips make data transfer safe and possible. Companies can safely transfer company related data for business activities online.

IC have become extremely important in today's world that almost everyone's lives are touched by the technology. With so much of importance in IC, imagine a scenario where someone, a hacker, a data thief or corporate espionage decides to take the chip and clone it and manufacture and sell the cloned chips at lower price. It would spell a death knell to the original manufacturer.

Before 1995, the cards had no mesh, the data bus was not scrambled and the data was not encrypted. Post 2000, passive mesh was introduced, data bus scrambling was introduced and data encryption was also introduced. Post 2005, many new technologies were introduced like implementing internal oscillator, active security mesh, encryption, bus scrambling, glitch sensors, voltage monitors, camo cells and custom internal oscillators.

1.2 Challenges to IC industry

Corporate espionage can add a “Trojan horse” in the chip. Trojan horse in a chip means the chip function will differ than the original design of the chip (Wang et al., 2008). It could either be overwriting the security features of the chip, bypass the encryption or write out crucial data from the chip.

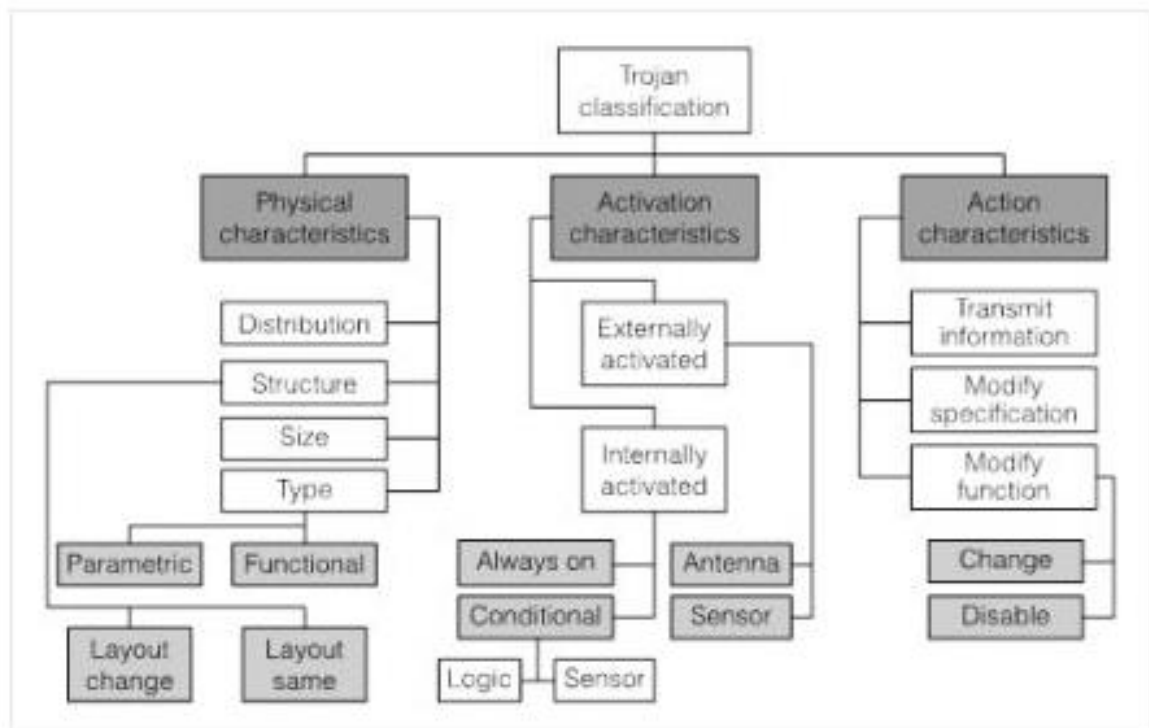


Figure 1-1 Trojan Horse (Wang et al., 2008)

Data thief would probe the IC on an ATM card or satellite decoders and steal the keys embedded in the card and use it to manufacture cloned cards. With the cards, the thief can withdraw cash from the ATM or use the satellite channels for free (Olivier Thomas BlackHat 2015). Both the actions would result in huge loss for the public and corporations.

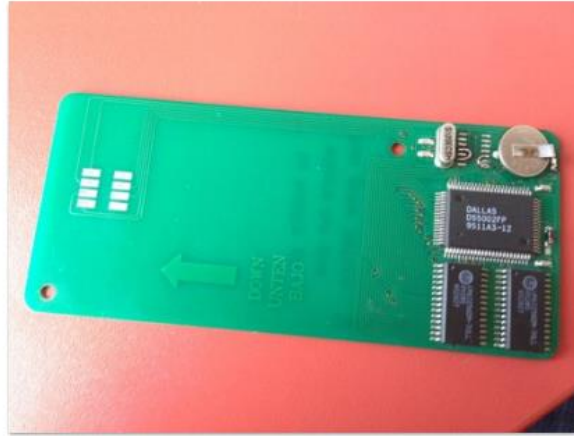


Figure 1-2 Hacked satellite decoder card (Olivier Thomas BlackHat 2015)

The effects would be worst if medical devices are cloned for profit as it would result in patients getting substandard or expired medical devices. Companies have invested millions in research and development of the devices. A hacker can steal the information on the chip and clone the product and sell it at lower cost. These activities are getting bigger by the year as the amount of money involved is huge and the interest shown by certain parties are encouraging.

The occurrence of counterfeit devices has been increasing at break neck pace lately and it is expected to get worse. It has infiltrated global electronic supply chain as the cost of counterfeit devices are lower. Hackers are improving their techniques making it very hard to detect counterfeit devices. (The hacker is also known as data thief or attacker).

The effect of these developments is a main cause of worry to manufacturers and also to consumers. Imagine a plane that is flying at high speed and the navigation system fails. That would be a nightmare scenario for the pilots.

Table 1-1 Top 5 most counterfeited semiconductors in 2011
(IHS Parts Management 2012)

Ranks	Component type	% of reported incidents
1	Analog IC	25.2
2	Microprocessor IC	13.4
3	Memory IC	13.1
4	Programmable logic IC	8.3
5	Transistors	7.6

The graph below shows the amount of counterfeit parts detected in global supply chain in the last few years. Hackers would take a chip, break it down layer by layer and duplicate the design and reproduce the chip at a fraction of the cost (Guin et al, 2014). For fabless manufacturers, supply chain security is a great concern as they would need to comb for genuine devices. Mass selling products like medical devices, consumer products like game consoles are targeted due to the size of the market.

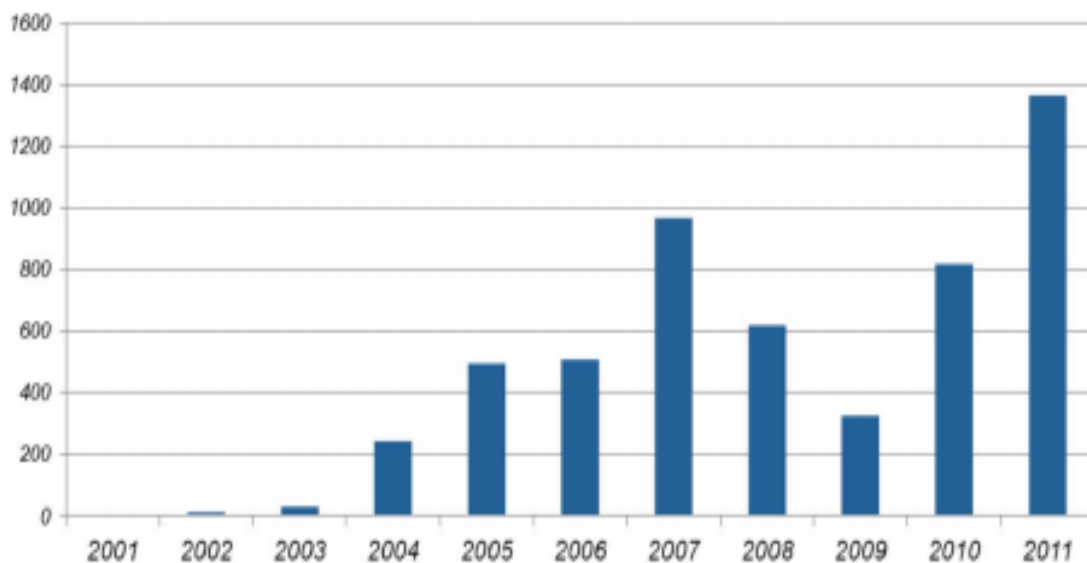


Figure 1-3 Reports of counterfeit (Guin et al., 2014)

1.3 Problem statement

Hackers are using advanced tools to read the memory and data bus on a chip. Therefore, a good active mesh need to be designed to deter the hackers. Active security mesh uses a significant amount of die area and in order to improve the effectiveness of the security mesh, more than 1 metal layer need to be used. That would increase the cost of the chip.

Active security mesh need to be running at all time to give the best protection for the chip it intends to protect. However, that would make the active security mesh unsuitable for low powered devices like mobile devices.

1.4 Aim and Objective

The objective of the thesis is to create an active mesh system that

- 1) Has high security, simple implementation, low cost and uses minimum area
- 2) Consumes lower power during idle and runs at higher frequency to maximize the protection for the chip

1.5 Scope

The scope of the research will be on the

- 1) design of active security blocks that utilizes minimum amount of area
- 2) design a mesh using single metal layer for both the mesh signals and power bus
- 3) design the active security mesh to use the lowest amount of power during idle
- 4) compare the power savings between spice simulation and power analysis

1.6 Thesis outline

There are 5 chapters that will be discussed in the thesis. By the end of the fifth chapter, the thesis should be able to prove the need of active security mesh and how easy it is to implement the mesh in a chip, what are the requirements and how to implement the mesh in low power devices.

Chapter 1 discusses the problem security problem that many IC manufacturer faces and the need for a low power active mesh.

Chapter 2 discusses about the current technologies that are available in the market. It discusses about the technologies are used to delayer the chip and reverse engineering

Chapter 3 discusses on the design and the methodologies that will be applied to design the active mesh

Chapter 4 will focus on the experiments done to implement the active mesh and the steps to reduce the power consumption.

Chapter 5 concludes the thesis with results of the experiments and explanations. It also includes future suggestion on how to make the chip more secure in the future.

CHAPTER 2

LITERATURE REVIEW

2.1 Overview

This chapter will discuss the current attack methods, types of metal mesh, evolution of security mesh, the available counter measures and the technologies used to do physical tampering. The latest trend in physical tampering is back side tampering. It will be discussed at the end of the chapter.

2.2 Current methods of attack

Physical attacks can be categorized as Invasive Attacks, Non-Invasive Attacks and Semi-Invasive Attacks.

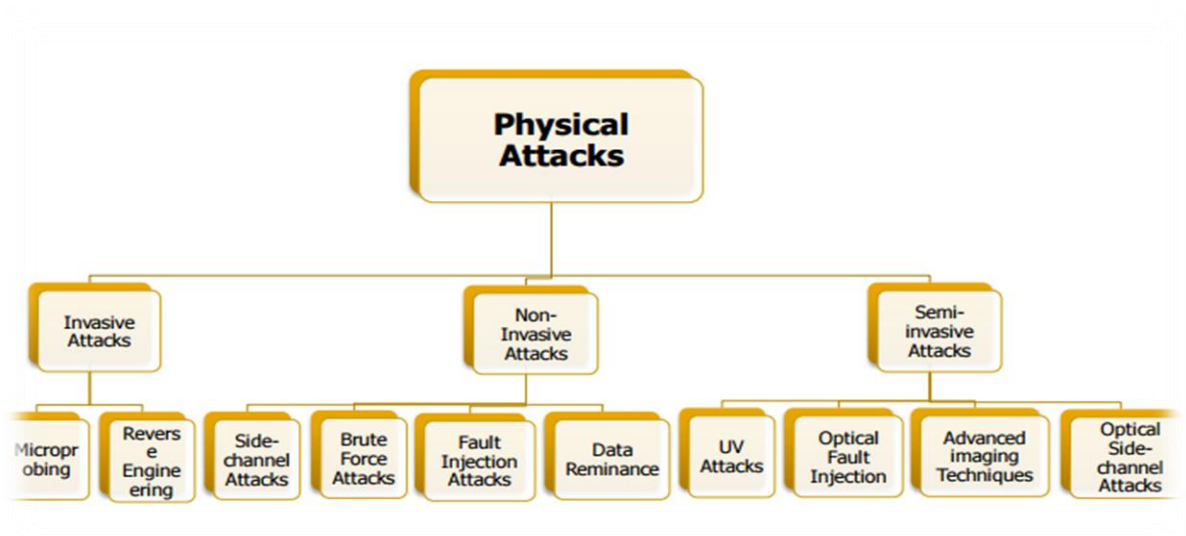


Figure 2-1: Classification of attacks (Tehranipoor, Mohammad, (2012))

Table 2-1: Types of attack and its characteristics (Tehranipoor, Mohammad, (2012))

Type of attack	characteristic	tools involved
invasive	require expensive equipments	FIB workstation
	requires decapsulation of package	laser cutting system
	attacker has good knowledge of chip architecture	microprobing workstation
	very destructive to the chip	SEM
	preferred method among attackers	
	capable of extracting informations and keys from the chip	
	good to eavesdrop on data	
semi invasive	not as expensive as invasive	UV light station
	requires decapsulation of package	optical microscopy
	uses UV to disable security fuses in volative memories	
non invasive	cheap and easily reproducible	board to plug in the chip
	takes some time to extract data	
	does not need to decapsulate the package	
	non-destructive to the chip	

In some reports, the attacks are classified as Hack, Shack, Lab and Fab attack. It can be a combination of direct physical attack, glitches, or through malware (Iqbal, 2013). Although the classifications are different, the attacks are similar to Fig.2-1. For example, Reverse Engineering is done in Lab Attack while Fault Injection is part of Shack Attack.

2.2.1 Hack Attack

The attacker executes viruses or malware into the device after initiating contact with the device. The contact could be direct physical contact or by wireless protocol. Usually the hacker would send a software claiming to be an update or add-on. When the user approves the installation, the malware embedded in the software would be installed also.

2.2.2 Shack Attack

The attack, like its name, is a low-cost hardware attack. The hardware to execute the attack can be bought from electronic hardware stores or online (Greg Wood, 2016). The attacker

would probe the signals, pins or busses using probes and network analyzers. The person would use test features in the IC like BIST, JTAG and boundary scan to probe the functional state. Usually the type of attack is quite simple like forcing the logic on the pins like logic 1 or 0, reprogramming the memory devices or bypassing some components.

2.2.3 Lab Attack

This type of attack is done by a group who has modern equipment and lab facilities. Usually will cost more and requires a higher expertise compare to hack and shack attack. The attackers would be able to reverse engineer the logic and memory, glitch the signal nets and scan the layout using electron microscope.

The attack on this scale would be able to perform cryptographic key analysis and analyze analog signals. The attacker can bridge IC chip net traces using FIB to reroute data or pins.

2.2.4 Fab Attack

This is the lowest form of attack where the attacker edits the layout and add additional monitor circuit into the layout. These edits are in GDS form and are done in foundry or fabrication plant. The advantage of this edit is that the edits cannot be detected by regular validation tools. It takes an experienced engineer to monitor the power or signal pattern to know that an attack is going on.

Overbuilding happens when the fab produces more than ordered part and uses the extra parts as counterfeits (Gedare Bloom et al, 2010). Stolen mask sets or the GDS database are known as fab attack.

2.3 Evolution of mesh

Chip security has been a big concern for some time. In the entertainment industry, satellite TV have huge customer pool and hackers see an opportunity to create and sell cloned cards. They used a variety of low cost micro probing techniques to steal the information from the cards. Shack attack, lab attack or invasive attack require micro probing into the chip. A good protection is needed to protect the chip against micro probing.

Mesh wires are made of additional metal layer on top of the die. Initially it does not carry any signal or clock nets. It just blocks the attacker from probing any of nets in the chip. The attackers managed to find a way to etch the mesh and expose the nets underneath the mesh wires.

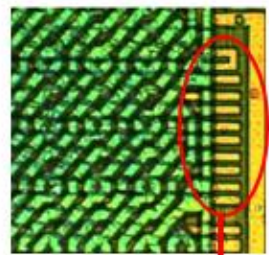
Etching the mesh layers is not very straight forward as the thickness of the mesh layers and glass oxide underneath the mesh would differ. Although chemical mechanical planarization polishes the surface to be near perfect flat, it is not meant for the top layer to be etched away. Once the top layer is etched using chemical process, the surface would not be evenly etched. All these have changed with probing and imaging technology advancement.

Passive security mesh was introduced later but it was later found that the mesh wires can be altered without triggering the alarm.

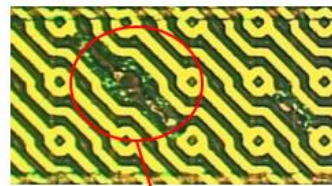
Active security mesh overcame the problem that passive security mesh faced. It monitors the mesh wires continuously for open or forced logics. The active meshes were implemented in many products available in the market. Active mesh was first introduced

in ST series smartcards. However, design flaws in active mesh made the chip vulnerable to attacks.

For example, ST16SF48A (Fig.2-2) chip has redundant extension of the bus that is not protected by the mesh, making it easy to be probed. Another chip had mesh interleaved with power and ground nets (Fig.2-3). The attacker simply removed a portion of the PG nets using FIB.



Bus not covered by the mesh



The mesh connected to power/ground bus can be removed without breaking the mesh connections

Figure 2-2 Exposed bus lines

Figure 2-3 Etched power mesh

2.4 Security mesh

The main objective of the security mesh is to prevent the hacker from physically probing the nets in the chip. Without the active mesh, a hacker can use a probe point (Fig.2-4) and read out the net information. The hacker would have no trouble reading out the decrypted keys when the chip is turned on. Probing is an invasive attack technique that hackers use to intercept secrets as well as forcing logics on the nets (Manich, S., et al, 2012).

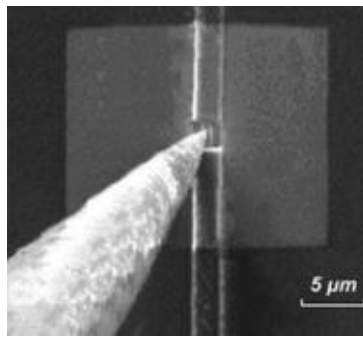


Figure 2-4: Example of probing (Young and Carleson, 2004)

There are 2 types of security mesh, passive and active mesh.

2.4.1 Passive mesh

Passive mesh uses analog passive mesh based on analog transmitter, analog receiver, driver and an evaluation device (Peter Laackmann, Hans Taddiken, 2003). The mesh uses capacitive measurement method to evaluate mesh. Alterations to the mesh can be undetected if the edits are small or the edited mesh has capacitance within the acceptable range (Cioranescu et al., 2014).

2.4.2 Active mesh

Passive mesh has a weakness that are exploited by hackers to remove the mesh layers. Active mesh (Fig.2-5) consists in injecting random sequences of bits through the mesh wires. The random signals are checked at the end of the mesh wires to check for any differences. These are usually digital in nature and cannot be altered by the hackers using external wires. The dissertation will discuss about active mesh.

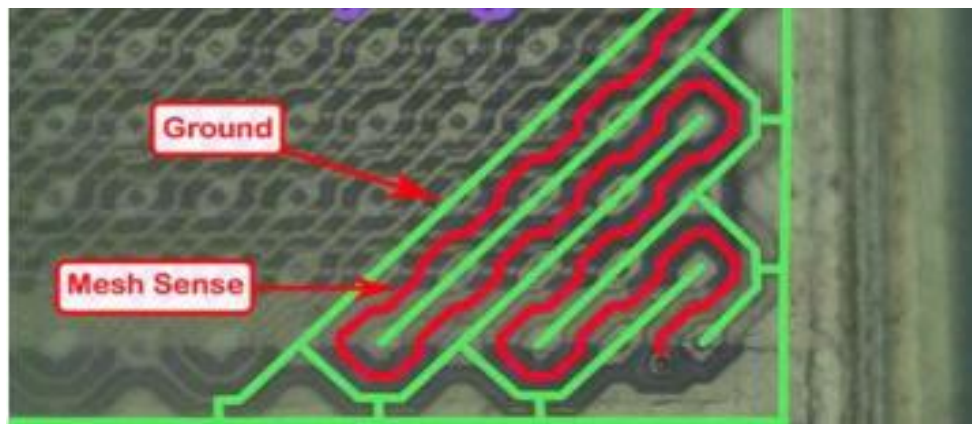


Figure 2-5: Example of active mesh (Tarnovsky, 2010)

Active and passive mesh do not protect against delayering. However, they do protect against dynamic attacks that occurs when the chip is rebooted or extraction of decrypted key from non-volatile memory. This data cannot be retrieved when the chip is in off state.

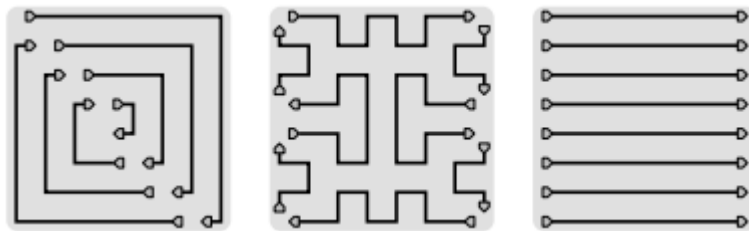


Figure 2-6 Example of active mesh structures (Cioranescu et al., 2014)

2.5 Dense Random Spaghetti Active Shield (DRSAS)

The concept behind DRSAS (Briais, et al., 2012) is to use 2 metal layers (metal 5 and metal6) and lay them in unpredictable pattern. The layout is so dense that there will be no tracks missed by either one of the 2 metal layers. It is called Hamiltonian path.

The algorithm for Hamiltonian path is described below as Table 2-2. (As taken from Briais, et al., 2012)

Input:	<i>N: number of different interleaved equipotentials</i>
Output:	<i>A random shield made of N equipotentials</i>
	<i>1: Build a graph whose vertices consists in free via slots and edges in the free routing slots</i>
	<i>2: Label each edge by a random number</i>
	<i>3: Solve the Traveling Salesman Problem (TSP) to get one Hamiltonian circuit</i>
	<i>4: Cut the Hamiltonian circuit into N subpaths, and return those.</i>

Table 2-2 Hamilton Algorithm

An example of DRSAS done using Table 2-2 is in Figure 2-7. This is quite an effective mesh but it uses 2 metal layers and 1 via layers. Therefore, the cost is higher.

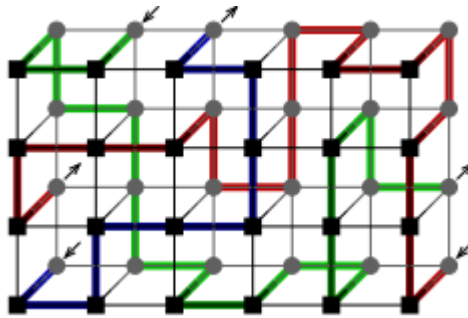


Figure 2-7 DRSAS

2.6 Other types of counter measures

Bus scrambling is a security technique that has been around since late 90s.



Figure 2-8 Example of data bus scrambling

The bus ordering in a chip is usually in order. For example, an 8 bit bus, the bus sequence is as follows. `mem_ports[7:0]=mem_bus[7,6,5,4,3,2,1,0]`.

Once the bus has been identified, the hacker can eavesdrop on the bus to read out the keys, or the boot sequence.

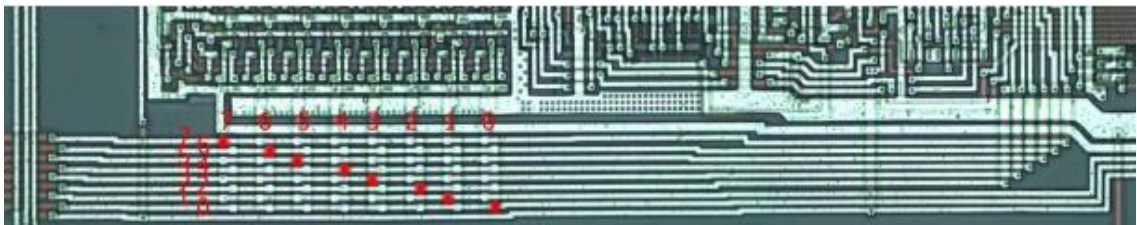


Figure 2-9 MCU 6805 core has the data bus in order (Motorola SC27/28 Smartcard)

The data buses are scrambled to throw the hacker of in different direction. The person would need to understand the chip design.

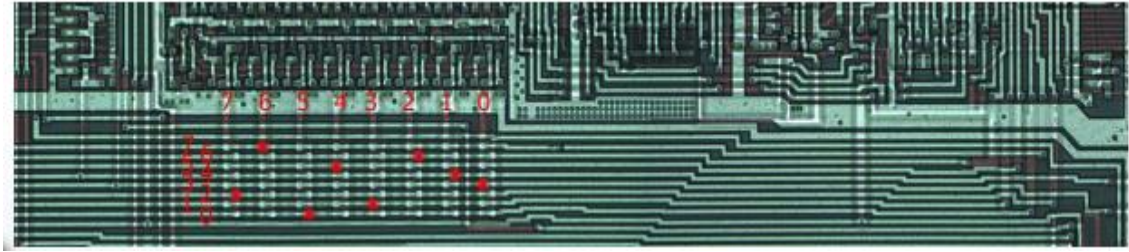


Figure 2-10 MCU 6805 core has the data bus scrambled (Motorola SC49 Smartcard)

The example above shows the bus lines that are swapped in the core. The bus sequence after it has been scrambled would be as follow

```
mem_ports[7:0]=mem_bus[6,2,4,1,0,7,3,5]
```

Light sensor and depassivation sensors were added to earlier chips to prevent the hackers from decapsulating the package or removing the mesh layers. However, the hackers managed to bypass that by doing selective etching.

Zeroization is another counter measure that was designed to protect the key in non-volatile memory. However, the mechanism requires power for it to work. Hackers would disable the mechanism before powering up the chip. It would only work for chips that are connected to battery-backed memories.

2.7 Methods and tools

2.7.1 Focused Ion Beam (FIB)

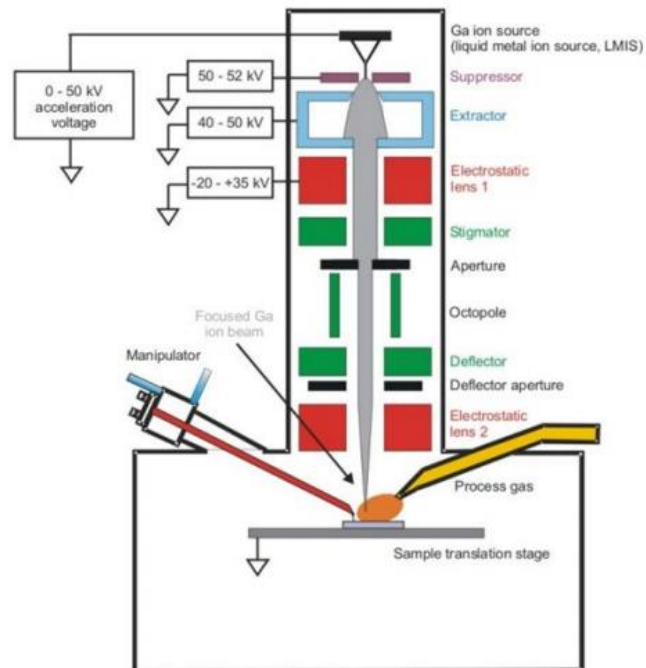


Figure 2-11 Example of FIB station (Image from http://www.brucherseifer.com/html/sem___fib.html)

Focused Ion Beams or FIB, is a tool that performs chip level surgery. The concept behind FIB is similar to SEM. FIB can be used for imaging, cut nets off and modifications to the nets. It uses energized Ga^+ ions.

FIB can image sample up to 5nm resolution. If the beam current is increased, FIB can be used to cut the metal. Attackers use FIB to do manual probing of metals that are embedded

deep in the die or the poly nets (if probe from the back side of the die). Once the hole is made to the net of interest, platinum will fill the hole to create a probe pad.

FIB can be used to modify layout on the die directly (Cole et al, 2009). This is very useful for a design and test engineer as they can perform a quick modification on the die to see if the edits can fix the chip failure (Fig.2-12). It is fairly quick to set up and use.

FIB workstations are very expensive to operate; therefore, most companies would rent the workstations on hourly basis.

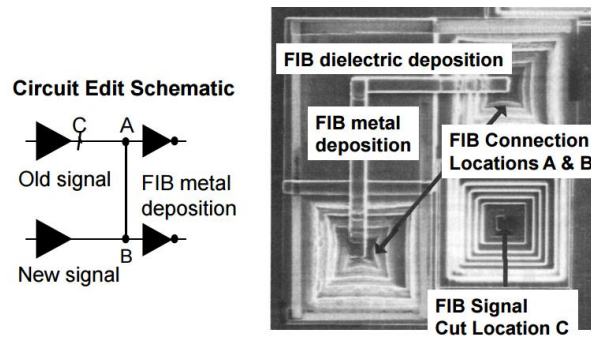


Figure 2-12: FIB edits (Cole et al., 2009)

However, FIB would be very costly for back side modifications. FIB requires an open area to do the modifications, the deeper the net, the larger the open area.



Figure 2-13 Physical IC Debug (Boit et al., 2008)

2.7.2 Scanning Electron Microscope

The chip can be delayered one layer at a time. Once delayered, Scanning Electron Microscope (SEM) are used to extract the image in high resolution. The images are fed into software like Photoshop where the images can be stacked on one another to study the chip. These technique is very useful in reverse engineering or understanding the mesh patterns. Tarnovsky (2010) has demonstrated the method and he used Photoshop to overlay the images.

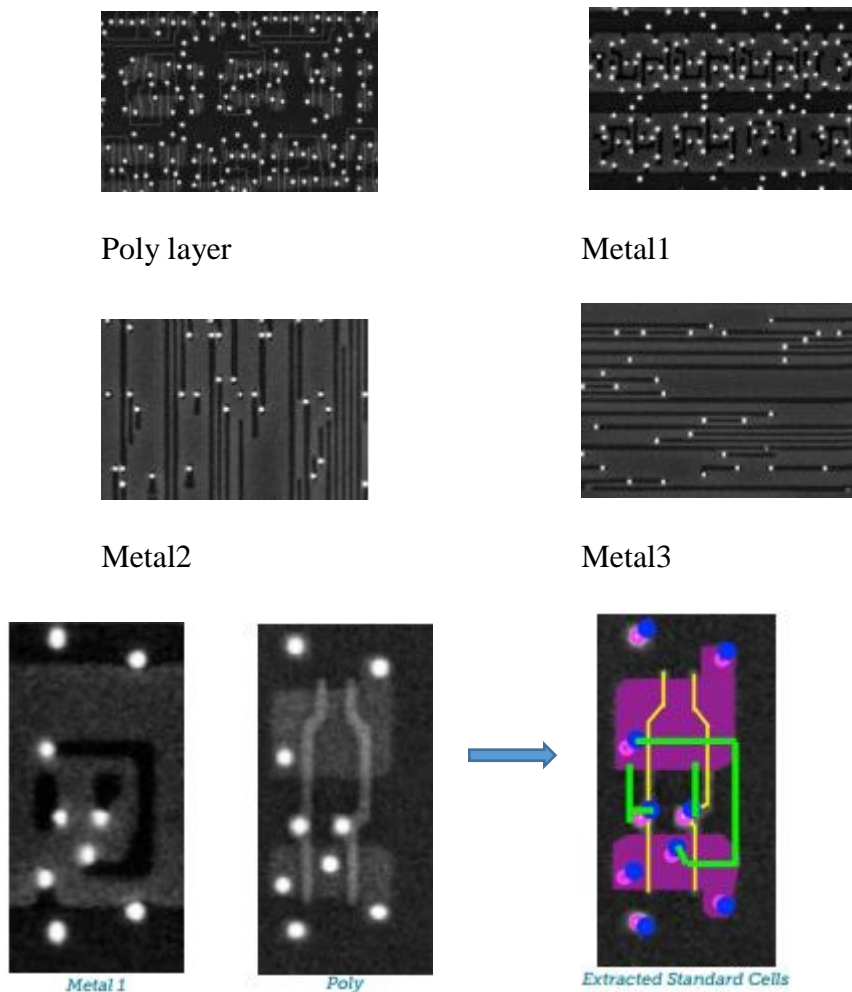


Figure 2-14 Reverse Engineering of a chip and standard cell (Thomas, 2015)

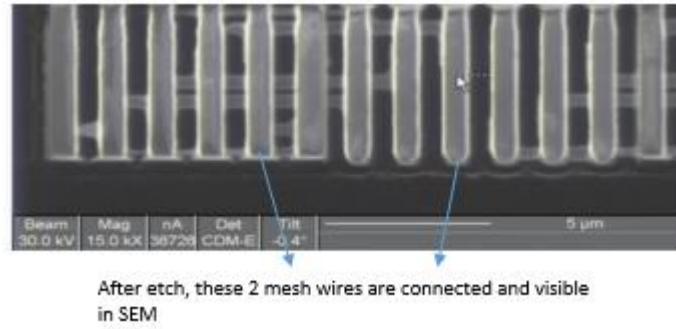


Figure 2-15 Image of mesh after the glass is etched away under SEM

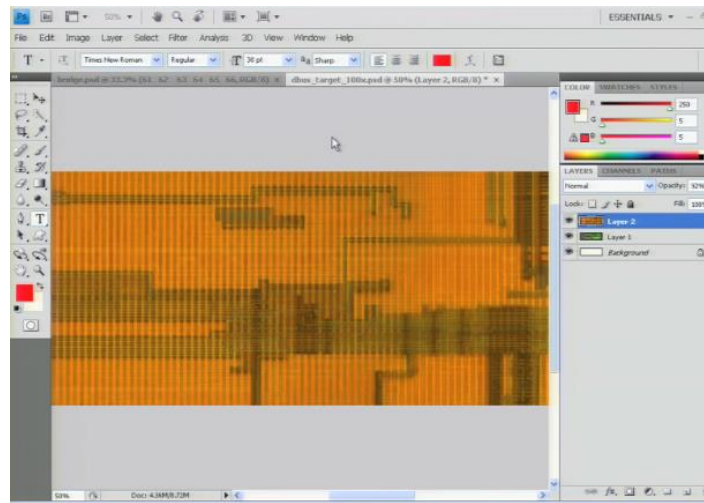


Figure 2-16 Layers being overlaid using Photoshop (Tarnovsky, 2010)

2.7.3 Low cost probing station

The cost of doing an invasive attack on an IC has come down and this plays a part in increasing the number of counterfeit devices in the market.

Invasive attacks mean probing the signal or clock nets using a probe. In order to do this, the chip package has to be removed and a decent probing station is required. Probing stations are made up of microscopes and controllable arm that can maneuver the fine probe or “cat whiskers” on the surface of the chip. Some has laser accessories to create a hole on the passivation layers. Usually these types of probing stations can be found in production line to do manual testing.

For package removal (in the case of epoxy package), the chip need to be dipped in nitric acid that has been heated to 60°C until the black epoxy dissolves. The chip is then soaked in ultrasonic acetone bath. If needed, wash the chip in deionized water and isopropanol.



Figure 2-17: Epoxy dissolved in hot nitric acid

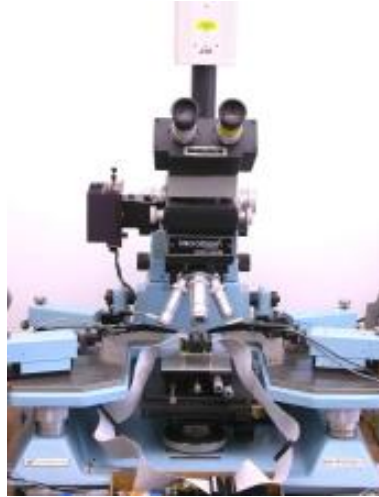


Figure 2-18: Low cost probing station

2.7.4 Probe Tips

As the IC technology shrinks, the net width also shrinks. Attacker would need a very fine probe tips to probe the nets. The tips are also called cat whisker. They have to use probe pins that are smaller than the metal width size else they would end up shorting the net. The technology behind the probe tips is quite impressive as some probe tip can be as small as 0.1um radius. It is mainly made of tungsten.

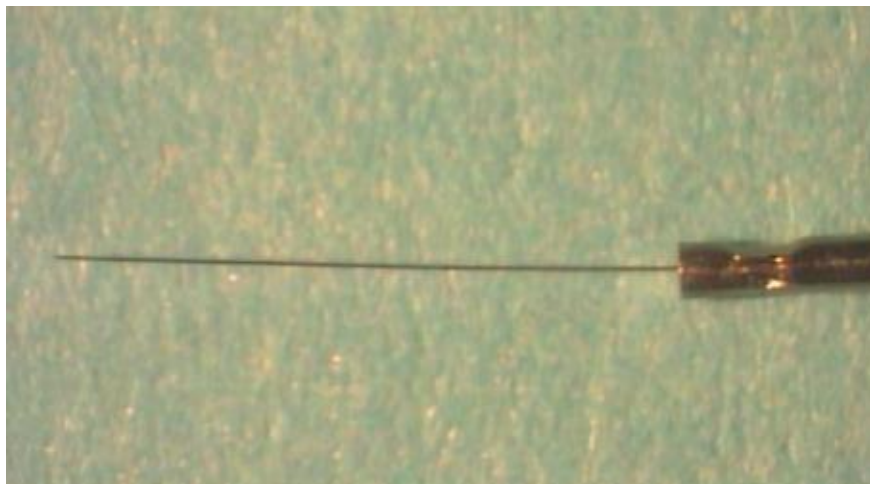


Figure 2-19 Probe tip

2.7.5 Back Probing

As technology in scanning and FIB advances, hackers have found new creative ways to tap into the die without touching the active mesh. Initially this technology was designed to help with chip test and failure analysis. The alarm would not go off and the hacker would be able to power up the chip to steal the data.

It was not very famous before as the hacker would not be able to FIB through the back side of the IC without damaging the diffusion layers and the person would be trying in the dark many times before he hits a correct clock or data bus. Moreover, the person would be able to probe first few metal layers only as probing deeper would require bigger area to FIB.

The preparation for back side probing require thinning of the silicon layer. This is usually done by FIB or Laser MicroChemical (LMC) Etching (Barton et al., 2004). FIB is quite accurate but costly. Figure 2-20 shows the attacker accesses the metal lines using backside FIB.

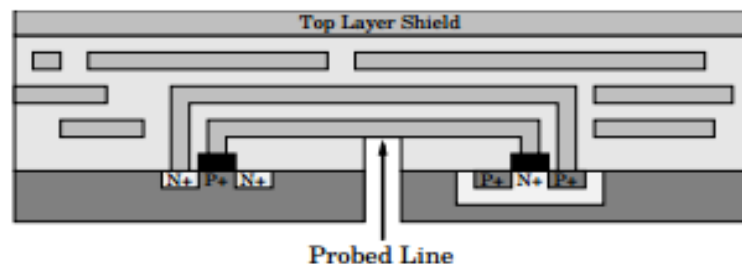


Figure 2-20: Back Side FIB